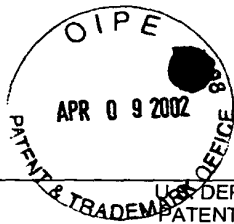


FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-335		SERIAL NO.	
<b>LIST OF DOCUMENTS CITED BY APPLICANT</b> <i>(Use several sheets if necessary)</i>				APPLICANT S. WATARI et al		GROUP	
				FILING DATE March 7, 2002			
<b>U.S. PATENT DOCUMENTS</b>							
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
DCM	AL	2000-105247	04/11/00	Japan (English Abstract Only)			<input type="checkbox"/> <input type="checkbox"/>
↓	AM	11-083865	03/26/99	Japan (English Abstract Only)			<input type="checkbox"/> <input type="checkbox"/>
	AN						<input type="checkbox"/> <input type="checkbox"/>
	AO						<input type="checkbox"/> <input type="checkbox"/>
	AP						<input type="checkbox"/> <input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AR						
	AS						
	AT						
EXAMINER <b>DAVID C. MEYER</b>				DATE CONSIDERED <b>5/1/03</b>			

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Sheet 1 of 1

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. NIT-335	SERIAL NO. 10/091,425
<b>LIST OF DOCUMENTS CITED BY APPLICANT</b> (Use several sheets if necessary)		APPLICANT S. WATARI et al	
		FILING DATE March 7, 2002	GROUP 2878

**U.S. PATENT DOCUMENTS**

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA					
	AB					
	AC					
	AD					
	AE					
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	AJ					
	AK					

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO YES NO	
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**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, etc.)

	AR						
	AS						
	AT						

EXAMINER <b>DAVID C. MEYER</b>	DATE CONSIDERED <b>5/1/03</b>
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